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·	Application/Control No.	Applicant(s)/Patent under Reexamination			
. :	10/695,803	SARWARY ET AL.			
	Examiner	Art Unit			
	Sun J. Lin	2825			

	SEARCHED				
Class	Subclass	Date	Examiner		
716	1	10/4/2005	JSL		
716	4	10/4/2005	JSL		
716	5	10/4/2005	JSL		
716	6	10/4/2005	JSL		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
			-		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	10/4/2005	JSL		
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	10/18/2005	JSL		
IEEE	10/4/2005	JSL		